

<b>Notice of References Cited</b>	Application/Control No. 09/898,043		Applicant(s)/Patent Under Reexamination HAYASHI	
	Examiner Johannes P Mondt		Art Unit 2826	Page 1 of 1

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.